

**Search Notes (continued)**

Application/Control No.

10/644,025

Examiner

Dwayne J. White

Applicant(s)/Patent under  
Reexamination

CHANG, SHUN-CHEN

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
updated		12/17/2004	DJW
updated		4/28/2005	DJW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See	printout	9/16/2005	DJW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

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**SEARCHED**

Class	Subclass	Date	Examiner
415	191		
	192		
	193		
	185		
	121.2		
	199.4		
	199.5		
	208.2		
	209.1		
	211.2		
	215.1		
	223		
361	695		
	697		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Updated from Parent case	7/22/2004	DJW
East text Search	7/22/2005	DJW